N-Channel Dual Gate MOS-Fieldeffect Tetrode, Depletion Mode

Electrostatic sensitive device. Observe precautions for handling.

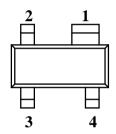


Applications

Input- and mixerstages especially for VHF TV-tuners.

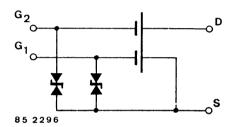
Features

- Integrated gate protection diodes
- High cross modulation performance
- Low noise figure



• High AGC-range

- Low feedback capacitance
- Low input capacitance



94 9279

BF994S: Marking Plastic case (SOT 143)

1 = Source; 2 = Drain; 3 = Gate 2; 4 = Gate 1

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Absolute Maximum Ratings

Parameters	Symbol	Value	Unit
Drain source voltage	V_{DS}	20	V
Drain current	I_D	30	mA
Gate 1/gate 2-source peak current	±I _{G1/2SM}	10	mA
Total power dissipation $T_{amb} = 60^{\circ}C$	P _{tot}	200	mW
Channel temperature	T _C	150	°C
Storage temperature range	T _{stg}	-55 to +150	°C

Maximum Thermal Resistance

Parameters	Symbol	Value	Unit
Channel ambient on glass fibre printed board			
$(40 \times 25 \times 1.5) \text{ mm}^3 \text{ plated with Cu } 35 \mu\text{m}$	R_{thChA}	450	K/W

BF 994 S

Electrical DC Characteristics

 $T_{amb} = 25$ °C, unless otherwise specified

Parameters / Test Conditions	Type	Symbol	Min.	Тур.	Max.	Unit
Drain-source breakdown voltage $I_D = 10 \mu A$, $-V_{G1S} = -V_{G2S} = 4 V$		V _{(BR)DS}	20			V
Gate 1-source breakdown voltage $\pm I_{G1S} = 10 \text{ mA}, V_{G2S} = V_{DS} = 0 \text{ V}$		±V _{(BR)G1SS}	6		20	V
Gate 2-source breakdown voltage $\pm I_{G2S} = 10 \text{ mA}, V_{G1S} = V_{DS} = 0 \text{ V}$		±V _{(BR)G2SS}			20	V
Gate 1-source cut-off current $\pm V_{G1S} = 5 \text{ V}, V_{G2S} = V_{DS} = 0 \text{ V}$		I_{G1SS}			50	nA
Gate 2-source cut-off current $\pm V_{G2S} = 5 \text{ V}, V_{G1S} = V_{DS} = 0 \text{ V}$		I_{G2SS}			50	nA
Drain current $V_{DS} = 15 \text{ V}, V_{G1S} = 0 \text{ V}, V_{G2S} = 4 \text{ V}$	BF 994 S BF 994 SA BF 994 SB	$I_{ m DSS} \ I_{ m DSS}$	4 4 9.5		18 10.5 18	mA mA mA
Gate 1-source cut-off voltage $V_{DS} = 15 \text{ V}, V_{G2S} = 4 \text{ V}, I_D = 20 \mu\text{A}$		-V _{G1S(OFF)}			2.5	V
Gate 2-source cut-off voltage $V_{DS} = 15 \text{ V}, V_{G1S} = 0 \text{ V}, I_D = 20 \mu\text{A}$		-V _{G2S(OFF)}			2.0	V

Electrical AC Characteristics

 $V_{DS} = 15 \text{ V}, I_D = 10 \text{ mA}, V_{G2S} = 4 \text{ V}, f = 1 \text{ MHz}, T_{amb} = 25^{\circ}\text{C}, \text{ unless otherwise specified}$

Parameters / Test Conditions	Type	Symbol	Min.	Тур.	Max.	Unit
Forward transadmittance		y ₂₁	15	17		mS
Gate 1-input capacitance		C _{issg1}		2.5	3.0	pF
Gate 2-input capacitance $V_{G1S} = 0 \text{ V}, V_{G2S} = 4 \text{ V}$		C _{issg2}		1.2		pF
Feedback capacitance		C_{rss}		25	35	fF
Output capacitance		Coss		1.0	1.3	pF
$\begin{aligned} & \text{Power gain} \\ & \text{V}_{DS} = 15 \text{ V}, \text{I}_{D} = 10 \text{ mA}, \text{V}_{G2S} = 4 \text{ V}, \\ & \text{g}_{G} = 2 \text{ mS}, \text{g}_{L} = 0.5 \text{ mS}, \text{f} = 200 \text{ MHz} \end{aligned}$		$G_{ m ps}$		25		dB
Noise figure $V_{DS}=15 \text{ V}, I_D=10 \text{ mA}, V_{G2S}=4 \text{ V}, \\ g_G=2 \text{ mS}, f=200 \text{ MHz}$		F		1.0		dB

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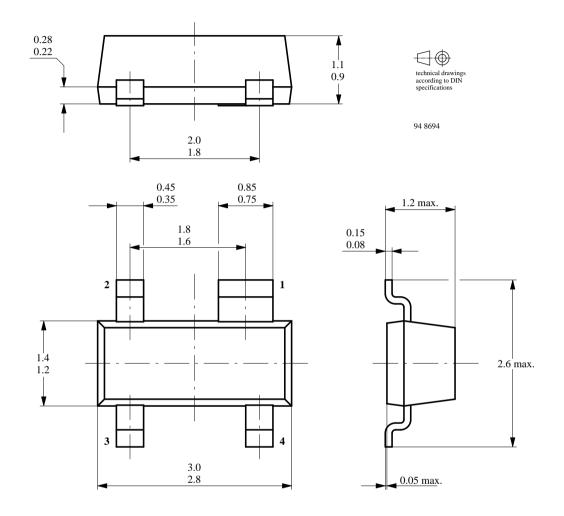
Common Source S-Parameters

 $V_{G2S} = 4 V$

	S ₁₁		11	S	21	S	12	S ₂₂		
V _{DS} /V	I _D /mA	f/MHz	LIN MAG	ANG	LIN MAG	ANG	LIN MAG	ANG	LIN MAG	ANG
				deg		deg		deg		deg
		50	1.00	-4.4	1.48	172.6	0.001	85.9	0.99	-1.8
		100	0.99	-8.5	1.46	165.0	0.001	81.9	0.99	-3.4
		150	0.99	-12.6	1.44	157.0	0.002	77.7	0.99	-5.2
		200	0.98	-16.8	1.41	149.6	0.003	74.5	0.98	-6.7
		250	0.97	-20.8	1.37	141.9	0.003	71.0	0.97	-8.4
		300	0.95	-24.6	1.35	135.2	0.004	67.9	0.97	-9.6
	5	350	0.94	-28.6	1.30	128.2	0.004	65.4	0.96	-11.1
		400	0.92	-32.0	1.27	121.7	0.004	63.0	0.95	-12.5
		450 500	0.91 0.89	−35.7 −39.1	1.23 1.19	115.3 108.9	0.005 0.005	60.6 58.1	0.94 0.93	-13.8 -15.1
		550	0.88	-39.1 -42.5	1.16	103.9	0.005	57.9	0.93	-15.1 -16.4
		600	0.86	-46.0	1.12	96.6	0.005	57.7	0.91	-17.6
		650	0.85	-49.3	1.09	91.2	0.005	57.7	0.91	-18.7
		700	0.84	-52.5	1.06	85.2	0.004	59.4	0.90	-19.9
		50	1.00	-4.5	1.85	172.8	0.001	86.3	0.99	-1.8
		100	1.00	-8.9	1.82	165.3	0.002	81.7	0.99	-3.4
		150	0.99	-13.3	1.80	157.5	0.002	77.6	0.98	-5.3
		200	0.98	-17.8	1.76	150.5	0.003	74.1	0.98	-6.7
		250	0.96	-22.0	1.71	143.2	0.004	70.4	0.97	-8.6
		300	0.95	-26.0	1.67	136.5	0.004	67.3	0.96	-9.7
15	10	350	0.94	-30.1	1.63	129.9	0.004	64.5	0.95	-11.4
		400	0.92	-33.8	1.58	123.5	0.005	61.9	0.95	-12.6
		450	0.90	-37.7	1.53	1175	0.005	59.5	0.94	-14.1
		500 550	0.89 0.87	-41.2 -44.9	1.49	11.2 105.5	0.005 0.005	56.7	0.93 0.92	-15.4
		600	0.87	-44.9 -48.4	1.44 1.40	99.4	0.005	56.6 56.1	0.92	-16.6 -17.8
		650	0.83	-51.8	1.36	95.5	0.005	55.8	0.91	-17.8 -18.9
		700	0.82	-55.1	1.32	88.8	0.005	57.3	0.89	-20.2
	15	50	1.00	-4.9	2.04	172.8	0.001	85.8	0.99	-1.8
		100	0.99	-9.5	2.01	165.4	0.001	81.4	0.98	-3.5
		150	0.99	-13.9	1.98	157.6	0.002	77.2	0.98	-5.4
		200	0.98	-18.5	1.94	150.7	0.003	73.4	0.97	-7.0
		250	0.96	-22.8	1.89	143.3	0.004	69.7	0.96	-8.8
		300	0.95	-26.9	1.84	136.8	0.004	66.5	0.96	-10.0
		350	0.93	-31.2	1.79	130.1	0.005	63.6	0.95	-11.6
		400	0.91	-35.1	1.74	124.1	0.005	60.9	0.94	-13.0
		450	0.90	-39.2	1.68	118.0	0.005	58.2	0.93	-14.3
		500	0.88	-42.9	1.63	111.7	0.005	55.4	0.92	-15.7
		550	0.86	-46.6	1.59	106.3	0.005	55.6	0.91	-16.9
		600	0.85	-50.2	1.54	100.3	0.005	55.0	0.90	-18.1
		650 700	0.83 0.81	-53.7 57.2	1.49 1.45	95.3 89.7	0.005 0.005	54.8 55.5	0.90 0.89	-19.3
		/00	0.81	-57.2	1.43	09.7	0.005	55.5	0.89	-20.7

BF 994 S

Dimensions in mm



TELEFUNKEN Semiconductors

Ozone Depleting Substances Policy Statement

It is the policy of **TEMIC TELEFUNKEN microelectronic GmbH** to

- 1. Meet all present and future national and international statutory requirements.
- 2. Regularly and continuously improve the performance of our products, processes, distribution and operating systems with respect to their impact on the health and safety of our employees and the public, as well as their impact on the environment.

It is particular concern to control or eliminate releases of those substances into the atmosphere which are known as ozone depleting substances (ODSs).

The Montreal Protocol (1987) and its London Amendments (1990) intend to severely restrict the use of ODSs and forbid their use within the next ten years. Various national and international initiatives are pressing for an earlier ban on these substances.

TEMIC TELEFUNKEN microelectronic GmbH semiconductor division has been able to use its policy of continuous improvements to eliminate the use of ODSs listed in the following documents.

- 1. Annex A, B and list of transitional substances of the Montreal Protocol and the London Amendments respectively
- 2. Class I and II ozone depleting substances in the Clean Air Act Amendments of 1990 by the Environmental Protection Agency (EPA) in the USA
- 3. Council Decision 88/540/EEC and 91/690/EEC Annex A, B and C (transitional substances) respectively.

TEMIC can certify that our semiconductors are not manufactured with ozone depleting substances and do not contain such substances.

We reserve the right to make changes without further notice to improve technical design.

Parameters can vary in different applications. All operating parameters must be validated for each customer application by customer. Should Buyer use TEMIC products for any unintended or unauthorized application, Buyer shall indemnify TEMIC against all claims, costs, damages, and expenses, arising out of, directly or indirectly, any claim of personal damage, injury or death associated with such unintended or unauthorized use.

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